

Notice of References Cited

Application/Control No.

10/565,320

Applicant(s)/Patent Under

Reexamination

MEYER ET AL.

Examiner

RENEE DANEGA

Art Unit

3736

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0108451	08-2002	May et al.	73/861.63
	B	US-			
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FOREIGN PATENT DOCUMENTS

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